

TRANSMITTAL

FORM

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09/770,997

January 25, 2001

Xinhui NIU and Nickhii JAKATDAR

Application Number

First Named Inventor

Filing Date

		Group Art Unit	2621		
(to be used for all correspondence after ini		Examiner Name	To Be Assigned		
Total Number Of Pages In This Submission	6 W/23 REFS	Attorney Docket No.	509982000100		
	ENCLOS	URES (check all that	apply)		
Fee Transmittal Form	Ass	ignment Papers an Application)	After Allowance Communication to Group		
Fee Attached	Dra	wing(s)	Appeal Communication to Board of Appeals and Interferences		
Amendment / Reply	Lice	Licensing-related Papers Appeal Communication (Appeal Notice, Brief, Inc.)			
After Final	Peti	tion	Proprietary Information		
Affidavits/declarations	Petil Prov	tion to Convert to a risional Application	Status Letter		
Extension of Time Request	Pow Cha	Other Enclosure(s) (please identify below):			
Express Abandonment Request	Terminal Disclaimer Form PTO-1449 (2 Pages) w/23 cite references Return Receipt Postcard				
Information Disclosure Statement (3 Pages)	_	Number of CD(s)	RECEIVED		
Certified Copy of Priority Document(s)	Remarks				
Response to Missing Parts/ Incomplete Application		_	APR 1 7 2002		
Response to Missing Parts under 37 CFR 1.52 or 1.53		Technology Center 2600			
SIGNATURE OF ARRUGANT ATTORNEY					
Firm or Peter J. Yim (Reg. No. 44,417) Morrison & Foerster LLP 425 Market Street San Francisco, California 94105-2482 Signature					
Date April 9, 2002	<u> </u>				
	OF DETERMINE AND ADDRESS OF THE PARTY OF THE				
CER	HIFICATE O	MAILING BY "FIRST CLA	SS MAIL"		

Burden Hours Statement: This form is estimated to take 0.2 hours to complete. Time will vary depending upon the needs of the individual case. Any comments on the amount of time you are required to complete this form should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, Washington, DC 20231. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Assistant Commissioner for Patents, Box Patent Application, Washington, DC 20231.

Janet Hollrah

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Janet Hollrah

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In the application of:

Xinhui NIU and Nickhil JAKATDAR

Serial No.: 09/770,997

Filing Date: January 25, 2001

For: CATCHING OF INTRA-LAYER

CALCULATIONS FOR RAPID RIGOROUS COUPLED-WAVE

ANALYSES

Examiner: To Be Assigned

Group Art Unit: 2621

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Technology Center 2600

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97

Assistant Commissioner for Patents Washington, D.C. 20231

Dear Sir:

Pursuant to 37 C.F.R. § 1.97 and § 1.98, Applicants submit for consideration in the above-identified application the documents listed on the attached Form PTO-1449. Copies of the documents are also submitted herewith. The Examiner is requested to make these documents of record.

This Information Disclosure Statement is submitted:

Ш	With	the application; accordingly, no fee or separate requirements are required.
\boxtimes	Within	n three months of the application filing date or before mailing of a first Office
	Action	n on the merits; accordingly, no fee or separate requirements are required.
	After	receipt of a first Office Action on the merits but before mailing of a final Office
	Action	n or Notice of Allowance.
		A fee is required. A check in the amount of * is enclosed.
		A fee is required. Accordingly, a Fee Transmittal form (PTO/SB/17) is attached
		to this submission in duplicate.
		A Certification under 37 C.F.R. § 1.97(e) is provided below; accordingly; no fee
		is believed to be due.
	After	mailing of a final Office Action or Notice of Allowance, but before payment of the
	issue 1	fee.
		A Certification under 37 C.F.R. § 1.97(e) is provided below and a check in the
		amount of * is enclosed.
		A Certification under 37 C.F.R. § 1.97(e) is provided below and a Fee Transmittal
		form (PTO/SB/17 is attached to this submission in duplicate.

Applicants would appreciate the Examiner initialing and returning the Form PTO-1449, indicating that the information has been considered and made of record herein.

The information contained in this Information Disclosure Statement under 37 C.F.R. § 1.97 is not to be construed as a representation that: (i) a complete search has been made; (ii) additional information material to the examination of this application does not exist; (iii) the information, protocols, results and the like reported by third parties are accurate or enabling; or (iv) the above information constitutes prior art to the subject invention.

In the unlikely event that the transmittal letter is separated from this document and the Patent Office determines that an extension and/or other relief is required, applicant petitions for any required relief including extensions of time and authorizes the Assistant Commissioner to charge the cost of such petitions and/or other fees due in connection with the filing of this

document to <u>Deposit Account No. 03-1952</u> referencing <u>509982000100</u>. However, the Assistant Commissioner is not authorized to charge the cost of the issue fee to the Deposit Account.

Dated: April 9, 2002

Respectfully submitted,

Peter V Yin

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San Francisco, California 94105-2482

Telephone: (415) 268-6373 Facsimile: (415) 268-7522 APR 1 2 2002

INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(Use several sheets if necessary)

Docket Number 509982000100 Application Number 09/770,997
Applicant

Xinhui NIU and Nickhil JAKATDAR

Filing Date January 25, 2001 Group Art Unit 2621

Mailing Date April 9, 2002

U.S. PATENT DOCUMENTS

Examiner Initials	Ref. No.	Date	Document No.	Name	Class	Subclass	Filing Date If Appropriate
	1.	7/21/92	5,131,752	Yu et al.			
	2.	11/17/92	5,164,790	McNeil et al.			
	3.	3/4/97	5,607,800	Ziger	F	FCFIVE	<u> </u>
	4.	4/14/98	5,739,909	Blayo et al.		POLIVE	
	5.	11/10/98	5,835,225	Thakur	А	PR 1 7 2002	
	6.	2/2/99	5,867,276	McNeil et al.	Techn	Norw Conton o	000
	7.	10/5/99	5,963,329	Conrad et al.	1001111	ology Center 2	600

FOREIGN PATENT DOCUMENTS

Examiner Initials	Ref. No.	Date	Document No.	Country	Class	Subclass	Trans YES	lation NO
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OTHER DOCUMENTS

(including author, title, Date, Pertinent Pages, Etc.,

		OTHER DOCUMENTS (including author, tille, Date, Pertinent Pages, Etc.)
Examiner Initials	Ref. No.	Title
	8. ′	N. W. Ashcroft et al., "Solid State Physics", Saunders College Philadelphia, 1976, pgs. 133-135.
	9	R. M. A. Azzam et al., "Ellipsometry and Polarized Light", Elsevier Science B. V., 1987, book.
	10. ~	Ch. M. Bishop, "Neural Networks for Pattern Recognition", Ch. 4, 1995, pp. 117-161.
	11	S. Bushman et al., "Scatterometry Measurements for Process Monitoring of Gate Etch", AEC/APC Workshop IX, Sematech, Sept. 20-24, 1997, pp. 148-158.
	12	G. Granet et al., "Efficient implementation of the coupled-wave method for metallic lamellar in TM polarization", J. Opt. Soc. Am. vol. 13, no. 5, May 1996, pp. 1019-1023.
	13. —	O. S. Heavens, "Optical Properties of Thin Solid Films", Dover Publications, Inc. 1955, book.
	14.	P. Lalanne et al., "Highly improved convergence of the coupled-wave method for TM polarization", J. Opt. Soc. Am. vol. 13, no. 4, April 1996, pp. 779-784.
	15. `	L. Li et al., "Convergence of the coupled-wave method for metallic lamellar diffraction gratings", J. Opt. Soc. Am. vol. 10, no. 6, June 1993, pp. 1184-1189.

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DATE CONSIDERED:

EXAMINER: Initial if citation considered, whether or not the citation conforms with MPEP 609. Draw a line through the citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.



INFORMATION SUBSTITUTE CITATION IN AN APPLICATION

(Use several sheets if necessary)

Docket Number 509982000100 Application Number 09/770,997

Applicant

Xinhui NIU and Nickhil JAKATDAR

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Group Art Unit 2621

Mailing Date

April 9, 2002

		Halling Balo Hall 7, 2002
16.		D. Maystre, "A new general integral theory for dielectric coated gratings", J. of Opt. Soc. of Amer.
		vol. 68 (4), Apr. 78, pp. 189-194.
17.		M. G. Moharam et al., "Rigorous coupled-wave analysis of planar-grating diffraction", J. Opt. Soc. Am. vol. 71, no. 7/July 1981, pp. 811-818.
18.		M. G. Moharam et al., "Formulation for stable and efficient implementation of the rigorous coupled-wave analysis of binary gratings", J. Opt. Soc. Am. vol. 12, no. 5, May 1995, pp. 1068-1076.
19.		Moharam et al., "Stable implementation of the rigorous coupled-wave analysis for surface - relief gratings: enhanced transmittance matrix approach", J. Opt. Soc. Am. vol. 12, no. 5, May 1995, pp. 1077-1086.
20.		M. Neviere et al., "Systematic Study of Resonances of Holographic Thin Film Couplers", Optics Com. vol. 9 (1), 1973, pp. 205-209.
21.	. ,	A. R. Neureuther et al., "Numerical Methods for the Analysis of Scattering from Nonplanar Periodic Structures", URSI Symposium on Electromag. Waves, 1969, pp. 185-188.
22.		W. H. Press et al., "Numerical Recipes in C", Art of Scien. Computing 2nd Ed., 1986, pp. 29-38.
23.		J. A. Rice, "Mathematical Statistics and Data Analysis" sec. ed., ch. 14, Duxbury Press, 1995, pp. 507-570.

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